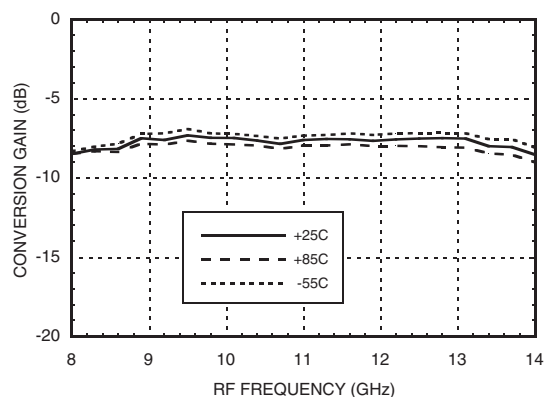
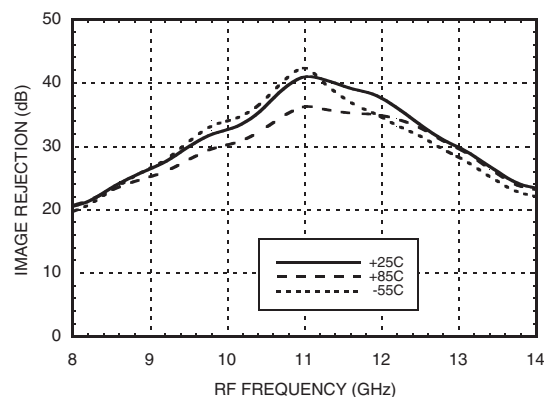
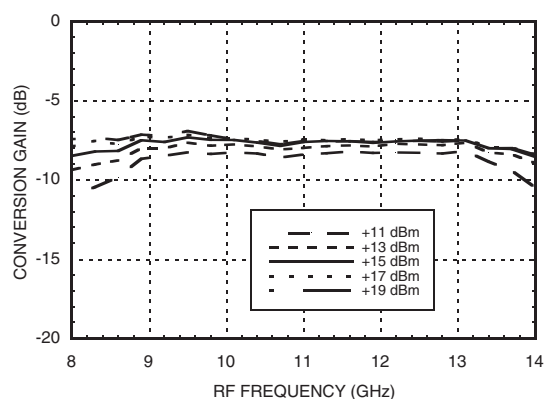
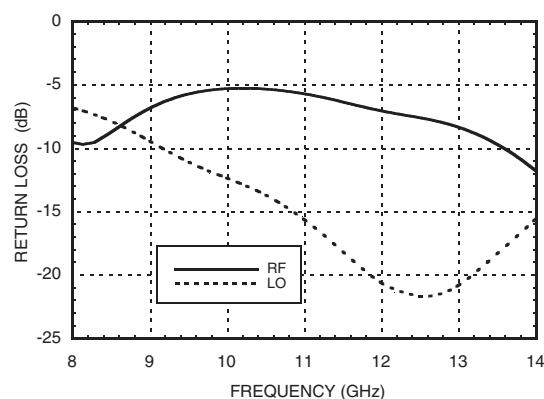
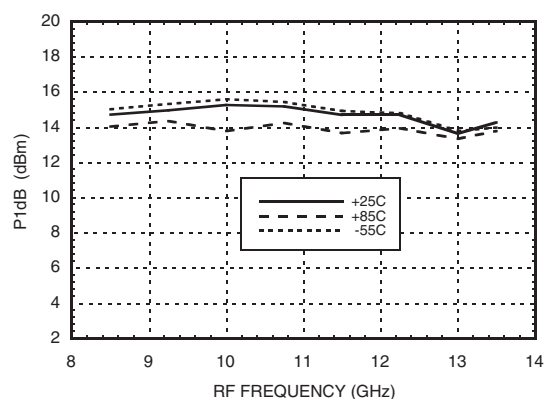
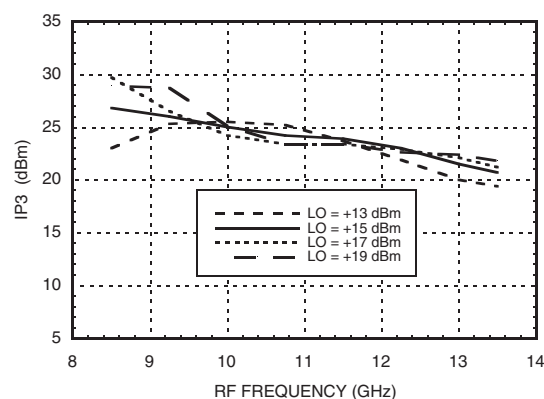
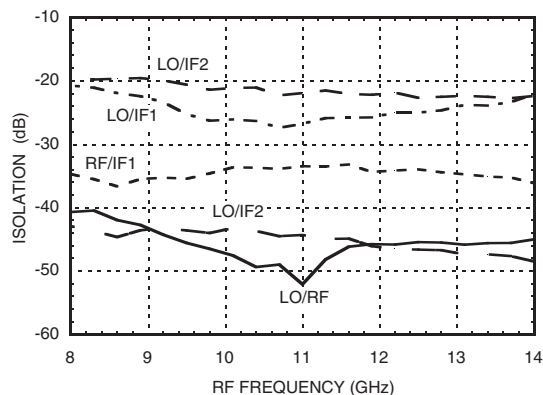
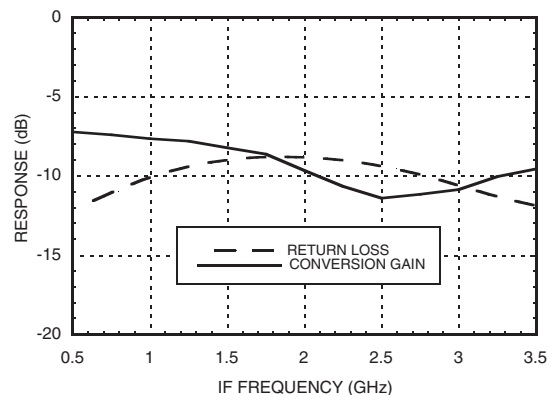
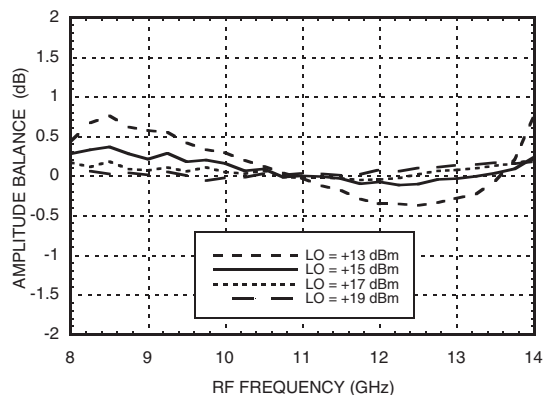
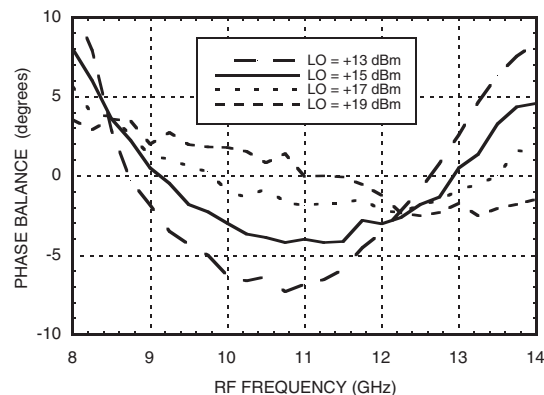
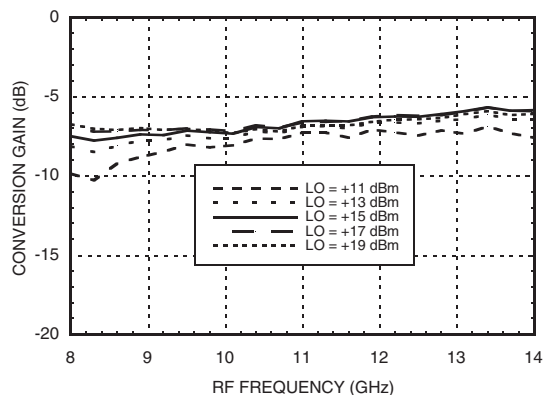
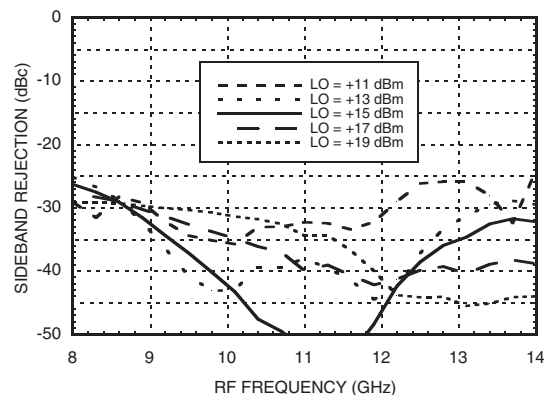


**GaAs MMIC I/Q MIXER
8.5 - 13.5 GHz**

Data Taken As IRM With External IF 90° Hybrid

Conversion Gain vs. Temperature

Image Rejection vs. Temperature

Conversion Gain vs. LO Drive

Return Loss

Input P1dB vs. Temperature

Input IP3 vs. LO Drive


**GaAs MMIC I/Q MIXER
8.5 - 13.5 GHz**
Quadrature Channel Data Taken Without IF 90° Hybrid
Isolations

IF Bandwidth*

Amplitude Balance vs. LO Drive

Phase Balance vs. LO Drive

Upconverter Performance Conversion Gain vs. LO Drive

Upconverter Performance Sideband Rejection vs. LO Drive


* Conversion gain data taken with external IF 90° hybrid

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GaAs MMIC I/Q MIXER 8.5 - 13.5 GHz

Harmonics of LO

| LO Freq. (GHz) | nLO Spur at RF Port | | | |
|----------------|---------------------|----|----|----|
| | 1 | 2 | 3 | 4 |
| 8.5 | 42 | 44 | 44 | 70 |
| 9.5 | 50 | 53 | 59 | 77 |
| 10.5 | 51 | 54 | 63 | xx |
| 11.5 | 47 | 58 | 66 | xx |
| 12.5 | 45 | 59 | 70 | xx |
| 13.5 | 45 | 57 | xx | xx |

LO = +15 dBm
Values in dBc below input LO level measured at RF Port.

MxN Spurious Outputs

| mRF | nLO | | | | |
|-----|-----|----|----|----|----|
| | 0 | 1 | 2 | 3 | 4 |
| 0 | xx | -5 | 29 | 23 | 52 |
| 1 | 27 | 0 | 51 | 59 | 81 |
| 2 | 92 | 85 | 76 | 82 | 92 |
| 3 | 92 | 92 | 92 | 92 | 92 |
| 4 | 92 | 92 | 92 | 92 | 92 |

RF = 10.6 GHz @ -10 dBm
LO = 10.5 GHz @ +15 dBm
Data taken without IF hybrid
All values in dBc below IF power level

Absolute Maximum Ratings

| | |
|-------------------------------------------------------------------------|-------------------|
| RF / IF Input | +20 dBm |
| LO Drive | +27 dBm |
| Channel Temperature | 150°C |
| Continuous P _{diss} (T=85°C) (derate 7.07 mW/°C above 85°C) | 460 mW |
| Thermal Resistance (R _{TH}) (junction to die bottom) | 141.4 °C/W |
| Storage Temperature | -65 to +150 °C |
| Operating Temperature | -55 to +85 deg °C |



**ELECTROSTATIC SENSITIVE DEVICE
OBSERVE HANDLING PRECAUTIONS**

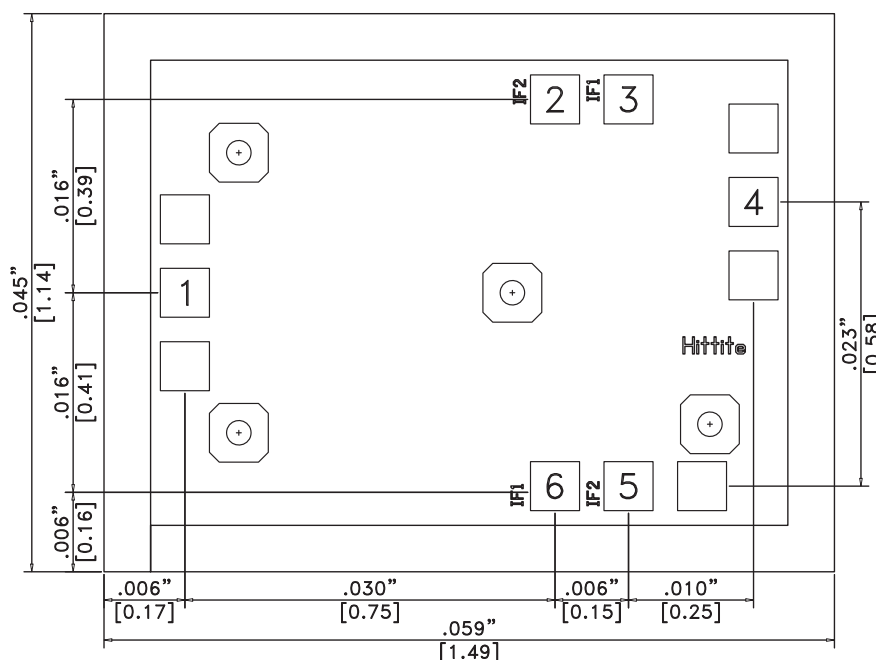
Die Packaging Information ^[1]

| Standard | Alternate |
|-----------------|-----------|
| GP-2 (Gel Pack) | [2] |

[1] Refer to the "Packaging Information" section for die packaging dimensions.

[2] For alternate packaging information contact Hittite Microwave Corporation.

Outline Drawing



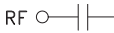
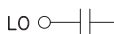
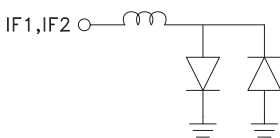

NOTES:

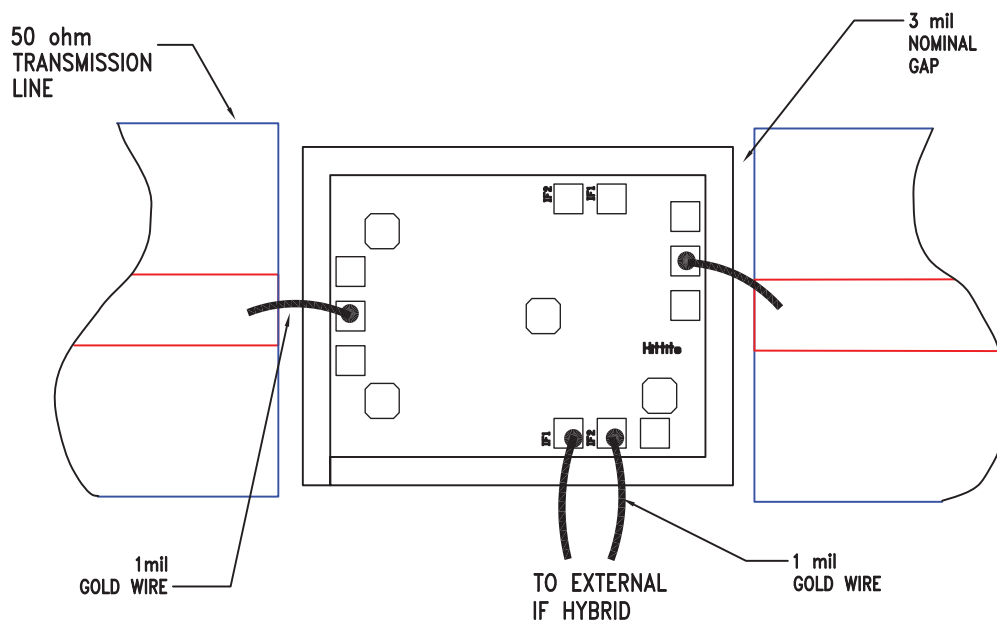
- ALL DIMENSIONS ARE IN INCHES [MM]
- DIE THICKNESS IS .004"
- TYPICAL BOND PAD IS .004"
- BACKSIDE METALIZATION: GOLD
- BOND PAD METALIZATION: GOLD
- BACKSIDE METAL IS GROUND
- CONNECTION NOT REQUIRED FOR UNLABELED BOND PADS.
- OVERALL DIE SIZE ±.002"

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**GaAs MMIC I/Q MIXER
8.5 - 13.5 GHz**
Pad Descriptions

| Pad Number | Function | Description | Interface Schematic |
|------------|----------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------|
| 1 | RF | This pad is AC coupled and matched to 50 Ohms. | RF  |
| 4 | LO | This pad is AC coupled and matched to 50 Ohms. | LO  |
| 2 (5) | IF2 | This pad is DC coupled. For applications not requiring operation to DC, this port should be DC blocked externally using a series capacitor whose value has been chosen to pass the necessary IF frequency range. For operation to DC, this pad must not source/sink more than 3mA of current or die non-function and possible die failure will result. Pads 5 and 6 are alternate IF ports. |  |
| 3 (6) | IF1 | | |
| | GND | The backside of the die must be connected to RF/DC ground. |  |

Assembly Diagrams


GaAs MMIC I/Q MIXER 8.5 - 13.5 GHz

Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be brought as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm (3 mils).

Handling Precautions

Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025 mm (1 mil) diameter pure gold wire is recommended. Thermosonic wirebonding with a nominal stage temperature of 150 °C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31 mm (12 mils).

